

AD5544/AD5554

FEATURES

AD5544 16-Bit Resolution

AD5554 14-Bit Resolution

2 mA Full-Scale Current $\pm 20\%$, with $V_{REF} = \pm 10$ V

2 μ s Settling Time

V_{SS} BIAS for Zero-Scale Error Reduction @ Temp

Midscale or Zero-Scale Reset

Four Separate 4Q Multiplying Reference Inputs

SPI-Compatible 3-Wire Interface

Double Buffered Registers Enable

Simultaneous Multichannel Change

Internal Power ON Reset

Compact SSOP-28 Package

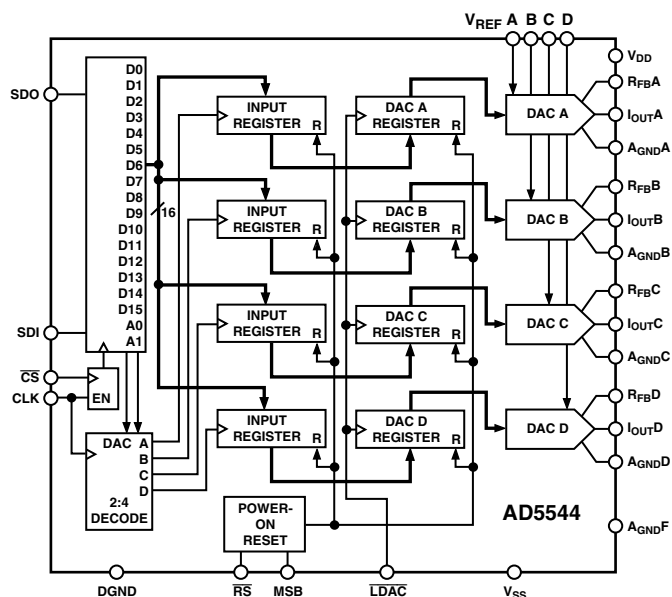
APPLICATIONS

Automatic Test Equipment

Instrumentation

Digitally-Controlled Calibration

FUNCTIONAL BLOCK DIAGRAM



GENERAL DESCRIPTION

The AD5544/AD5554 quad, 16-/14-bit, current-output, digital-to-analog converters are designed to operate from a single 5 V supply.

The applied external reference input voltage (V_{REF}) determines the full-scale output current. Integrated feedback resistors (R_{FB}) provide temperature-tracking, full-scale voltage outputs when combined with an external I-to-V precision amplifier.

A doubled-buffered serial-data interface offers high-speed, 3-wire, SPI- and microcontroller-compatible inputs using serial-data-in (SDI), clock (CLK), and a chip-select ($\overline{CS}$). In addition, a serial-data-out pin (SDO) allows for daisy-chaining when multiple packages are used. A common level-sensitive load-DAC strobe ($\overline{LDAC}$) input allows simultaneous update of all DAC outputs from previously loaded input registers. Additionally, an internal power ON reset forces the output voltage to zero at system turn ON. An MSB pin allows system reset assertion ($\overline{RS}$) to force all registers to zero code when MSB = 0, or to half-scale code when MSB = 1.

AD5544/AD5554 are packaged in the compact SSOP-28.

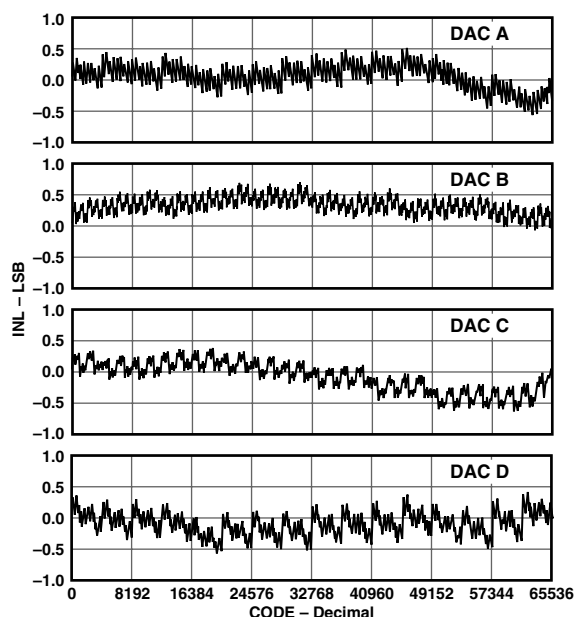


Figure 1. AD5544 INL vs. Code Plot ($T_A = 25^\circ\text{C}$)

REV. 0

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AD5544/AD5554—SPECIFICATIONS

(@ $V_{DD} = 5\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $I_{OUTX} = \text{Virtual GND}$, $A_{GNDX} = 0\text{ V}$, $V_{REFA}, B, C, D = 10\text{ V}$, $T_A = \text{Full Operating Temperature Range}$, unless otherwise noted.)

AD5544 ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Condition	Min	Typ	Max	Unit
STATIC PERFORMANCE¹						
Resolution	N	1 LSB = $V_{REF}/2^{16} = 153\text{ }\mu\text{V}$ when $V_{REF} = 10\text{ V}$			16	Bits
Relative Accuracy	INL				± 4	LSB
Differential Nonlinearity	DNL				± 1.5	LSB
Output Leakage Current	I_{OUTX}	Data = 0000 _H , $T_A = 25^\circ\text{C}$			10	nA
	I_{OUTX}	Data = 0000 _H , $T_A = T_A \text{ Max}$			20	nA
Full-Scale Gain Error	G_{FSE}	Data = FFFF _H		± 0.75	± 3	mV
Full-Scale Tempco ²	TCV_{FS}			1		ppm/ $^\circ\text{C}$
Feedback Resistor	R_{FBX}	$V_{DD} = 5\text{ V}$	4	6	8	k Ω
REFERENCE INPUT						
V_{REFX} Range	V_{REFX}		-15		+15	V
Input Resistance	R_{REFX}		4	6	8	k Ω
Input Resistance Match	R_{REFX}	Channel-to-Channel		1		%
Input Capacitance ²	C_{REFX}			5		pF
ANALOG OUTPUT						
Output Current	I_{OUTX}	Data = FFFF _H	1.25		2.5	mA
Output Capacitance ²	C_{OUTX}	Code-Dependent		80		pF
LOGIC INPUTS AND OUTPUT						
Logic Input Low Voltage	V_{IL}				0.8	V
Logic Input High Voltage	V_{IH}		2.4			V
Input Leakage Current	I_{IL}				1	μA
Input Capacitance ²	C_{IL}				10	pF
Logic Output Low Voltage	V_{OL}	$I_{OL} = 1.6\text{ mA}$			0.4	V
Logic Output High Voltage	V_{OH}	$I_{OH} = 100\text{ }\mu\text{A}$	4			V
INTERFACE TIMING^{2, 3}						
Clock Width High	t_{CH}		25			ns
Clock Width Low	t_{CL}		25			ns
$\overline{CS}$ to Clock Setup	t_{CSS}		0			ns
Clock to $\overline{CS}$ Hold	t_{CSH}		25			ns
Clock to SDO Prop Delay	t_{PD}		2		20	ns
Load DAC Pulswidth	t_{LDAC}		25			ns
Data Setup	t_{DS}		20			ns
Data Hold	t_{DH}		20			ns
Load Setup	t_{LDS}		5			ns
Load Hold	t_{LDH}		25			ns
SUPPLY CHARACTERISTICS						
Power Supply Range	$V_{DD \text{ RANGE}}$		4.5		5.5	V
Positive Supply Current	I_{DD}	Logic Inputs = 0 V		50	250	μA
Negative Supply Current	I_{SS}	Logic Inputs = 0 V, $V_{SS} = -5\text{ V}$		0.001	1	μA
Power Dissipation	P_{DISS}	Logic Inputs = 0 V			1.25	mW
Power Supply Sensitivity	PSS	$\Delta V_{DD} = \pm 5\%$			0.006	%/%

NOTES

¹All static performance tests (except I_{OUT}) are performed in a closed-loop system using an external precision OP177 I-to-V converter amplifier. The AD5544 R_{FB} terminal is tied to the amplifier output. Typical values represent average readings measured at 25°C .

²These parameters are guaranteed by design and not subject to production testing.

³All input control signals are specified with $t_R = t_F = 2.5\text{ ns}$ (10% to 90% of 3 V) and timed from a voltage level of 1.5 V.

Specifications subject to change without notice.

(@ $V_{DD} = 5\text{ V} \pm 10\%$, $V_{SS} = -300\text{ mV}$, $I_{OUTX} = \text{Virtual GND}$, $A_{GNDX} = 0\text{ V}$,
 $V_{REFA}, B, C, D = 10\text{ V}$, $T_A = \text{full operating temperature range}$, unless
otherwise noted.)

AD5544 ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Condition	Min	Typ	Max	Unit
AC CHARACTERISTICS¹						
Output Voltage Settling Time	t_S	To $\pm 0.1\%$ of Full Scale, Data = 0000 _H to FFFF _H to 0000 _H		1		μs
Output Voltage Settling Time	t_S	To $\pm 0.0015\%$ of Full Scale, Data = 0000 _H to FFFF _H to 0000 _H		2		μs
Reference Multiplying BW	BW -3 dB	$V_{REFX} = 100\text{ mV rms}$, Data = FFFF _H , $C_{FB} = 15\text{ pF}$		2		MHz
DAC Glitch Impulse	Q	$V_{REFX} = 10\text{ V}$, Data 0000 _H to 8000 _H to 0000 _H		1.2		nV-s
Feedthrough Error	V_{OUTX}/V_{REFX}	Data = 0000 _H , $V_{REFX} = 100\text{ mV rms}$, $f = 100\text{ kHz}$		-65		dB
Crosstalk Error	V_{OUTA}/V_{REFB}	Data = 0000 _H , $V_{REFB} = 100\text{ mV rms}$, Adjacent Channel, $f = 100\text{ kHz}$		-90		dB
Digital Feedthrough	Q	$\overline{CS} = 1$, and $f_{CLK} = 1\text{ MHz}$		5		nV-s
Total Harmonic Distortion	THD	$V_{REF} = 5\text{ V p-p}$, Data = FFFF _H , $f = 1\text{ kHz}$		-90		dB
Output Spot Noise Voltage	e_N	$f = 1\text{ kHz}$, BW = 1 Hz		7		$\text{nV}/\sqrt{\text{Hz}}$

NOTES

¹All ac characteristic tests are performed in a closed-loop system using an OP42 I-to-V converter amplifier.

Specifications subject to change without notice.

AD5544/AD5554—SPECIFICATIONS

AD5554 ELECTRICAL CHARACTERISTICS

(@ $V_{DD} = 5\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $I_{OUTX} = \text{Virtual GND}$, $A_{GNDX} = 0\text{ V}$,
 $V_{REFA, B, C, D} = 10\text{ V}$, $T_A = \text{full operating temperature range}$,
 unless otherwise noted.)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
STATIC PERFORMANCE¹						
Resolution	N	1 LSB = $V_{REF}/2^{14} = 610\text{ }\mu\text{V}$ when $V_{REF} = 10\text{ V}$			14	Bits
Relative Accuracy	INL				± 1	LSB
Differential Nonlinearity	DNL				± 1	LSB
Output Leakage Current	I_{OUTX}	Data = 0000 _H , $T_A = 25^\circ\text{C}$			10	nA
	I_{OUTX}	Data = 0000 _H , $T_A = T_A \text{ Max}$			20	nA
Full-Scale Gain Error	G_{FS}	Data = 3FFF _H		± 2	± 10	mV
Full-Scale Tempco ²	TCV_{FS}			1		ppm/ $^\circ\text{C}$
Feedback Resistor	R_{FBX}	$V_{DD} = 5\text{ V}$	4	6	8	k Ω
REFERENCE INPUT						
V_{REFX} Range	V_{REFX}		-15		+15	V
Input Resistance	R_{REFX}		4	6	8	k Ω
Input Resistance Match	R_{REFX}	Channel-to-Channel		1		%
Input Capacitance ²	C_{REFX}			5		pF
ANALOG OUTPUT						
Output Current	I_{OUTX}	Data = 3FFF _H	1.25		2.5	mA
Output Capacitance ²	C_{OUTX}	Code-Dependent		80		pF
LOGIC INPUTS AND OUTPUT						
Logic Input Low Voltage	V_{IL}				0.8	V
Logic Input High Voltage	V_{IH}		2.4			V
Input Leakage Current	I_{IL}				1	μA
Input Capacitance ²	C_{IL}				10	pF
Logic Output Low Voltage	V_{OL}	$I_{OL} = 1.6\text{ mA}$			0.4	V
Logic Output High Voltage	V_{OH}	$I_{OH} = 100\text{ }\mu\text{A}$	4			V
INTERFACE TIMING^{2, 3}						
Clock Width High	t_{CH}		25			ns
Clock Width Low	t_{CL}		25			ns
$\overline{CS}$ to Clock Setup	t_{CSS}		0			ns
Clock to $\overline{CS}$ Hold	t_{CSH}		25			ns
Clock to SDO Prop Delay	t_{PD}		2		20	ns
Load DAC Pulsewidth	t_{LDAC}		25			ns
Data Setup	t_{DS}		20			ns
Data Hold	t_{DH}		20			ns
Load Setup	t_{LDS}		5			ns
Load Hold	t_{LDH}		25			ns
SUPPLY CHARACTERISTICS						
Power Supply Range	$V_{DD \text{ RANGE}}$		4.5		5.5	V
Positive Supply Current	I_{DD}	Logic Inputs = 0 V		50	250	μA
Negative Supply Current	I_{SS}	Logic Inputs = 0 V, $V_{SS} = -5\text{ V}$		0.001	1	μA
Power Dissipation	P_{DISS}	Logic Inputs = 0 V			1.25	mW
Power Supply Sensitivity	PSS	$\Delta V_{DD} = \pm 5\%$			0.006	%/%

NOTES:

¹All static performance tests (except I_{OUT}) are performed in a closed-loop system using an external precision OP177 I-to-V converter amplifier. The AD5554 R_{FB} terminal is tied to the amplifier output. Typical values represent average readings measured at 25°C .

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B, C, D = 10 V , T_A = full operating temperature range, unless otherwise
noted.)

AD5554 ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Condition	Min Typ Max	Unit
AC CHARACTERISTICS¹				
Output Voltage Settling Time	t_S	To $\pm 0.1\%$ of Full Scale, Data = 0000_H to $3FFF_H$ to 0000_H	1	μs
Output Voltage Settling Time	t_S	To $\pm 0.0015\%$ of Full Scale, Data = 0000_H to $3FFF_H$ to 0000_H	2	μs
Reference Multiplying BW	BW -3 dB	$V_{REFX} = 100\text{ mV rms}$, Data = $3FFF_H$, $C_{FB} = 15\text{ pF}$	2	MHz
DAC Glitch Impulse	Q	$V_{REFX} = 10\text{ V}$, Data 0000_H to 2000_H to 0000_H	1.2	nV-s
Feedthrough Error	V_{OUTX}/V_{REFX}	Data = 0000_H , $V_{REFX} = 100\text{ mV rms}$, $f = 100\text{ kHz}$	-65	dB
Crosstalk Error	V_{OUTA}/V_{REFB}	Data = 0000_H , $V_{REFB} = 100\text{ mV rms}$, Adjacent Channel, $f = 100\text{ kHz}$	-90	dB
Digital Feedthrough	Q	$\overline{CS} = 1$, and $f_{CLK} = 1\text{ MHz}$	5	nV-s
Total Harmonic Distortion	THD	$V_{REF} = 5\text{ V p-p}$, Data = $3FFF_H$, $f = 1\text{ kHz}$	-90	dB
Output Spot Noise Voltage	e_N	$f = 1\text{ kHz}$, BW = 1 Hz	7	$\text{nV}/\sqrt{\text{Hz}}$

NOTES:

¹All ac characteristic tests are performed in a closed-loop system using an OP42 I-to-V converter amplifier.

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS*

V_{DD} to GND	-0.3 V, +8 V
V_{SS} to GND	+0.3 V, -7 V
V_{REF} to GND	-18 V, +18 V
Logic Inputs and Output to GND	-0.3 V, +8 V
$V(I_{OUT})$ to GND	-0.3 V, $V_{DD} + 0.3\text{ V}$
A_{GNDX} to DGND	-0.3 V, +0.3 V
Input Current to Any Pin Except Supplies	$\pm 50\text{ mA}$
Package Power Dissipation	$(T_J \text{ MAX} - T_A)/\theta_{JA}$
Thermal Resistance θ_{JA}	
28-Lead Shrink Surface-Mount (RS-28)	100°C/W
Maximum Junction Temperature ($T_J \text{ MAX}$)	150°C

Operating Temperature Range

Model A -40°C to +85°C

Storage Temperature Range -65°C to +150°C

Lead Temperature:

RS-28 (Vapor Phase, 60 secs) 215°C

RS-28 (Infrared, 15 secs) 220°C

*Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ORDERING GUIDE

Model	RES Bit	INL LSB	DNL LSB	Temperature Range	Package Description	Package Option
AD5544ARS	16	± 4	± 1.5	-40/+85°C	SSOP-28	RS-28
AD5554BRS	14	± 1	± 1	-40/+85°C	SSOP-28	RS-28

The AD5544/AD5554 contain 4196 transistors. The die size is 122 mil $\times$ 204 mil.

CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD5544/AD5554 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



AD5544/AD5554

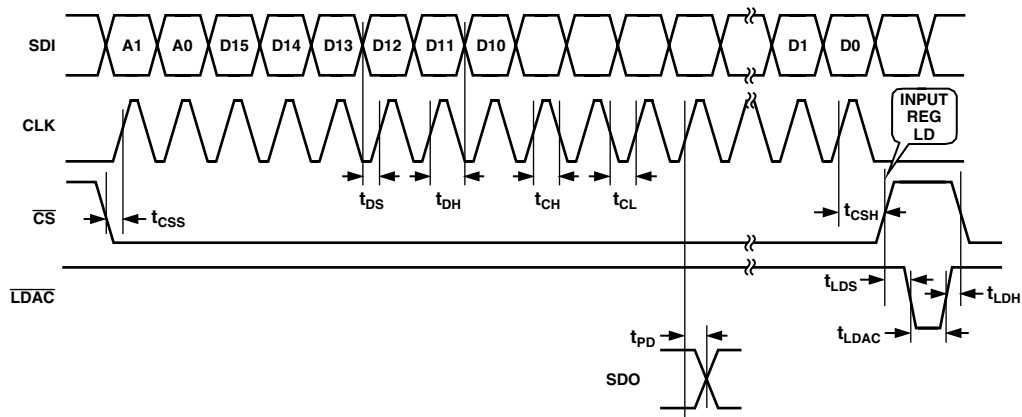


Figure 2. AD5544 Timing Diagram

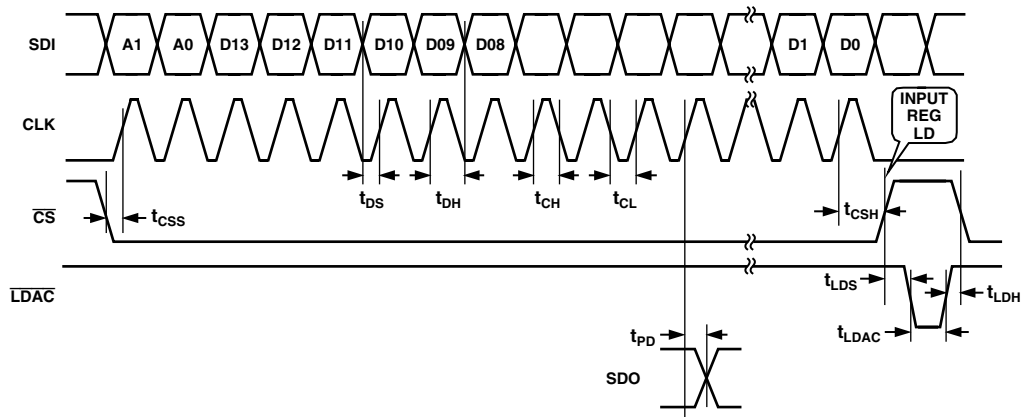


Figure 3. AD5554 Timing Diagram

Table I. AD5544 Control-Logic Truth Table

$\overline{CS}$	CLK	$\overline{LDAC}$	$\overline{RS}$	MSB	Serial Shift Register Function	Input Register Function	DAC Register
H	X	H	H	X	No Effect	Latched	Latched
L	L	H	H	X	No Effect	Latched	Latched
L	$\uparrow+$	H	H	X	Shift-Register-Data Advanced One Bit	Latched	Latched
L	H	H	H	X	No Effect	Latched	Latched
$\uparrow+$	L	H	H	X	No Effect	Selected DAC Updated with Current SR Contents	Latched
H	X	L	H	X	No Effect	Latched	Transparent
H	X	H	H	X	No Effect	Latched	Latched
H	X	$\uparrow+$	H	X	No Effect	Latched	Latched
H	X	H	L	0	No Effect	Latched Data = 0000 _H	Latched Data = 0000 _H
H	X	H	L	H	No Effect	Latched Data = 8000 _H	Latched Data = 8000 _H

Table II. AD5554 Control-Logic Truth Table

$\overline{\text{CS}}$	CLK	$\overline{\text{LDAC}}$	$\overline{\text{RS}}$	MSB	Serial Shift Register Function	Input Register Function	DAC Register
H	X	H	H	X	No Effect	Latched	Latched
L	L	H	H	X	No Effect	Latched	Latched
L	$\uparrow+$	H	H	X	Shift-Register-Data Advanced One Bit	Latched	Latched
L	H	H	H	X	No Effect	Latched	Latched
$\uparrow+$	L	H	H	X	No Effect	Selected DAC Updated with Current SR Contents	Latched
H	X	L	H	X	No Effect	Latched	Transparent
H	X	H	H	X	No Effect	Latched	Latched
H	X	$\uparrow+$	H	X	No Effect	Latched	Latched
H	X	H	L	0	No Effect	Latched Data = 0000 _H	Latched Data = 0000 _H
H	X	H	L	H	No Effect	Latched Data = 2000 _H	Latched Data = 2000 _H

NOTES

1. SR = Shift Register.
2. $\uparrow+$ positive logic transition; X = Don't Care.
3. At power ON both the Input Register and the DAC Register are loaded with all zeros.
4. For AD5544, data appears at the SDO Pin 19 clock pulses after input at the SDI pin.
5. For AD5554, data appears at the SDO Pin 17 clock pulses after input at the SDI pin.

Table III. AD5544 Serial Input Register Data Format, Data Is Loaded in the MSB-First Format

MSB										LSB								
Bit Position	B17	B16	B15	B14	B13	B12	B11	B10	B9	B8	B7	B6	B5	B4	B3	B2	B1	B0
Data Word	A1	A0	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0

NOTE

Only the last 18 bits of data clocked into the serial register (Address + Data) are inspected when the $\overline{\text{CS}}$ line's positive edge returns to logic high. At this point an internally generated load strobe transfers the serial register data contents (Bits D15–D0) to the decoded DAC-Input-Register address determined by bits A1 and A0. Any extra bits clocked into the AD5544 shift register are ignored, only the last 18 bits clocked in are used. If double-buffered data is not needed, the $\overline{\text{LDAC}}$ pin can be tied logic low to disable the DAC Registers.

Table IV. AD5554 Serial Input Register Data Format, Data Is Loaded in the MSB-First Format

MSB															LSB	
Bit Position	B15	B14	B13	B12	B11	B10	B9	B8	B7	B6	B5	B4	B3	B2	B1	B0
Data Word	A1	A0	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0

NOTE

Only the last 16 bits of data clocked into the serial register (Address + Data) are inspected when the $\overline{\text{CS}}$ line's positive edge returns to logic high. At this point an internally generated load strobe transfers the serial register data contents (Bits D13–D0) to the decoded DAC-Input-Register address determined by bits A1 and A0. Any extra bits clocked into the AD5554 shift register are ignored, only the last 16 bits clocked in are used. If double-buffered data is not needed, the $\overline{\text{LDAC}}$ pin can be tied logic low to disable the DAC Registers.

Table V. Address Decode

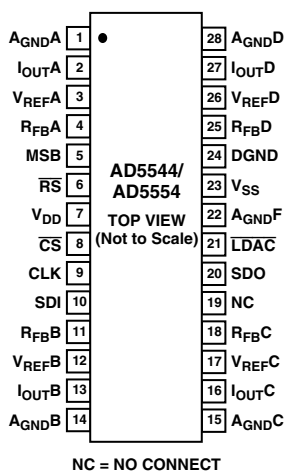
A1	A0	DAC Decoded
0	0	DAC A
0	1	DAC B
1	0	DAC C
1	1	DAC D

AD5544/AD5554

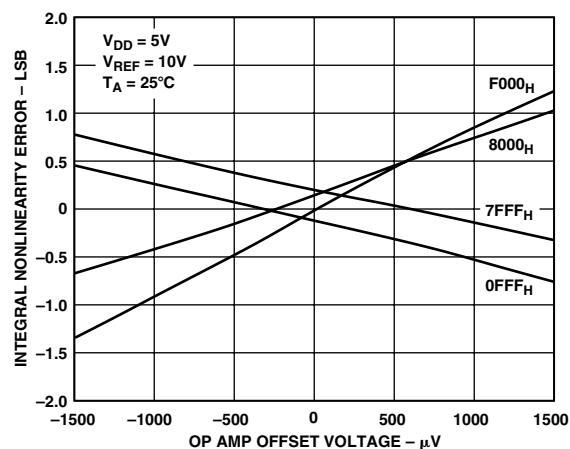
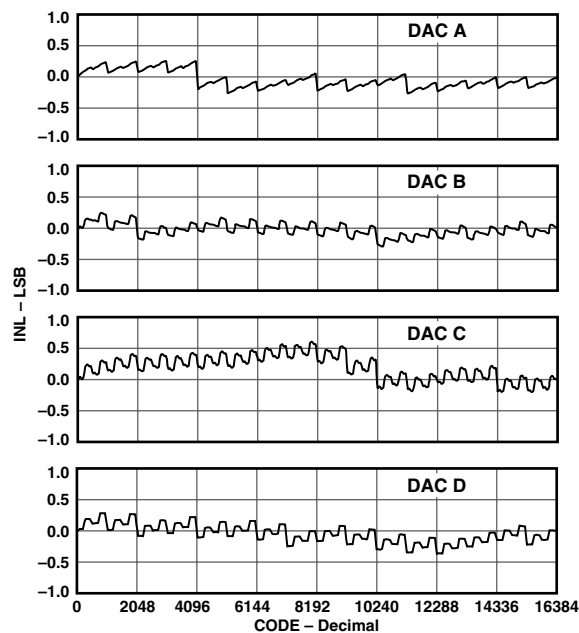
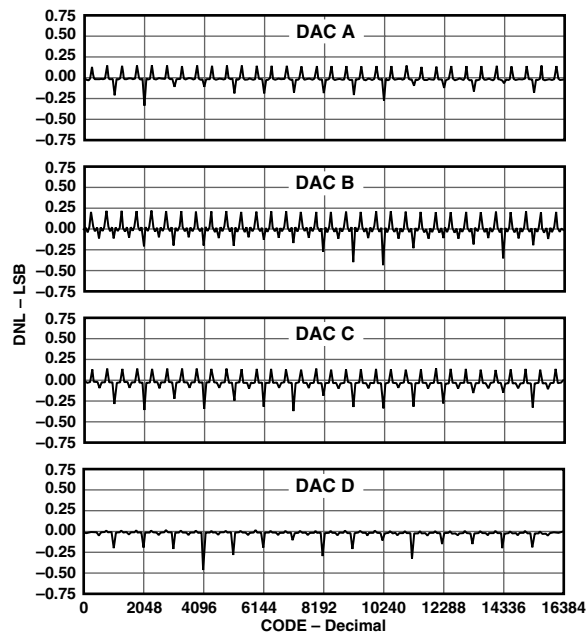
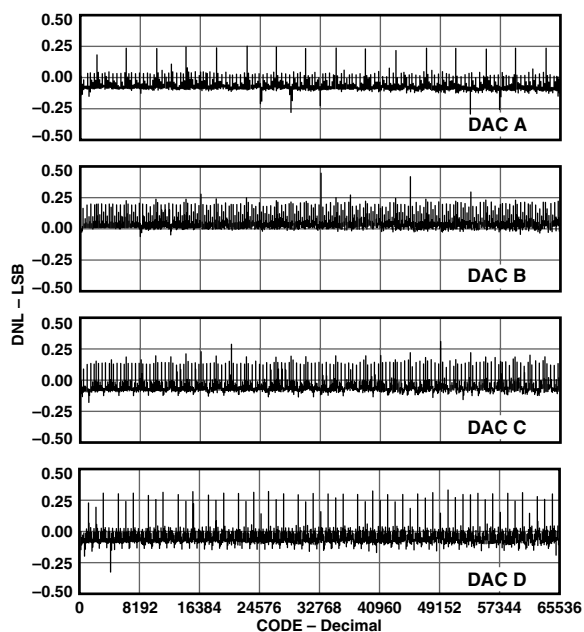
AD5544/AD5554 PIN FUNCTION DESCRIPTIONS

Pin #	Name	Function
1	AGND _A	DAC A Analog Ground.
2	I _{OUTA}	DAC A Current Output.
3	V _{REFA}	DAC A Reference Voltage Input Terminal. Establishes DAC A full-scale output voltage. Pin can be tied to V _{DD} pin.
4	R _{FBA}	Establish Voltage Output for DAC A by Connecting to External Amplifier Output.
5	MSB	MSB Bit Set Pin During a Reset Pulse ($\overline{RS}$) or at System Power ON if Tied to Ground or V _{DD} .
6	$\overline{RS}$	Reset Pin, Active Low Input. Input registers and DAC registers are set to all zeros or half-scale code (8000 _H for AD5544 and 2000 _H for AD5554) determined by the voltage on the MSB pin. Register Data = 0000 _H when MSB = 0. Register Data = 8000 _H for AD5544 and 2000 _H for AD5554 when MSB = 1.
7	V _{DD}	Positive Power Supply Input. Specified range of operation 5 V $\pm$ 10%.
8	$\overline{CS}$	Chip Select, Active Low Input. Disables shift register loading when high. Transfers serial register data to the Input Register when $\overline{CS}/\overline{LDAC}$ returns High. Does not effect $\overline{LDAC}$ operation.
9	CLK	Clock Input, Positive Edge Clocks Data into Shift Register.
10	SDI	Serial Data Input, Input Data Loads Directly into the Shift Register.
11	R _{FBB}	Establish Voltage Output for DAC B by Connecting to External Amplifier Output.
12	V _{REFB}	DAC B Reference Voltage Input Terminal. Establishes DAC B full-scale output voltage. Pin can be tied to V _{DD} pin.
13	I _{OUTB}	DAC B Current Output.
14	AGND _B	DAC B Analog Ground.
15	AGND _C	DAC C Analog Ground.
16	I _{OUTC}	DAC C Current Output.
17	V _{REFC}	DAC C Reference Voltage Input Terminal. Establishes DAC C full-scale output voltage. Pin can be tied to V _{DD} pin.
18	R _{FBC}	Establish voltage output for DAC C by connecting to external amplifier output.
19	NC	No Connect. Leave pin unconnected.
20	SDO	Serial Data Output, input data loads directly into the shift register. Data appears at SDO, 19 clock pulses for AD5544 and 17 clock pulses for AD5554 after input at the SDI pin.
21	$\overline{LDAC}$	Load DAC Register Strobe, Level Sensitive Active Low. Transfers all Input Register data to DAC registers. Asynchronous active low input. See Control Logic Truth Table for operation.
22	AGND _F	High Current Analog Force Ground.
23	V _{SS}	Negative Bias Power Supply Input. Specified range of operation -0.3 V to -5.5 V.
24	DGND	Digital Ground Pin.
25	R _{FBD}	Establish Voltage Output for DAC D by Connecting to External Amplifier Output.
26	V _{REFD}	DAC D Reference Voltage Input Terminal. Establishes DAC D full-scale output voltage. Pin can be tied to V _{DD} pin.
27	I _{OUTD}	DAC D Current Output.
28	AGND _D	DAC D Analog Ground.

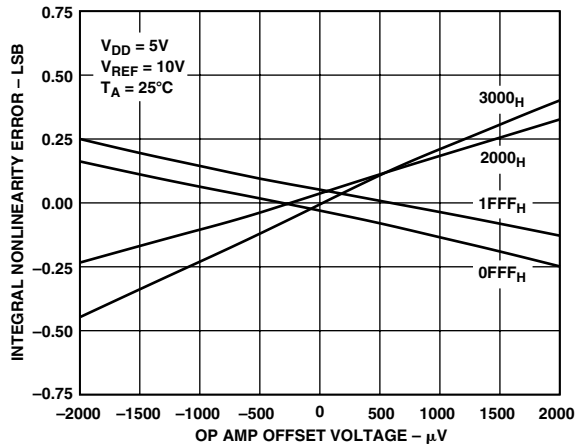
AD5544/AD5554 PIN CONFIGURATION



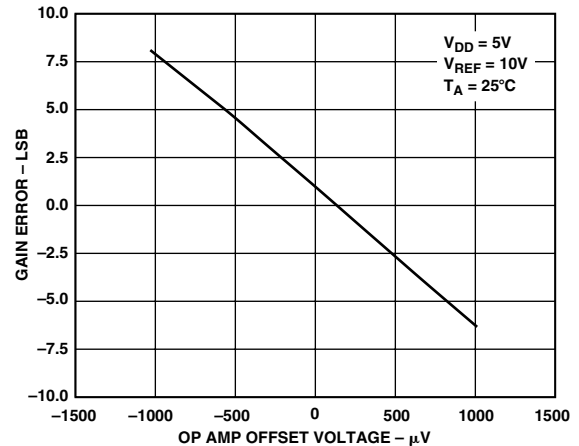
Typical Performance Characteristics—AD5544/AD5554



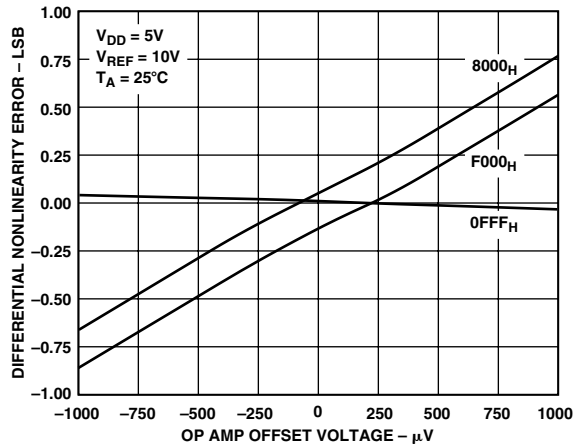
AD5544/AD5554



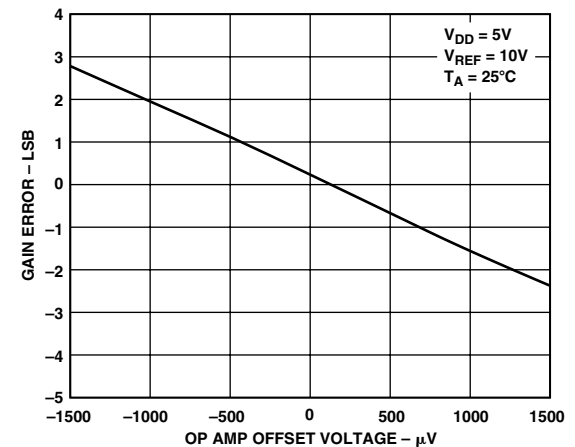
TPC 5. AD5554 Integral Nonlinearity Error vs. Op Amp Offset



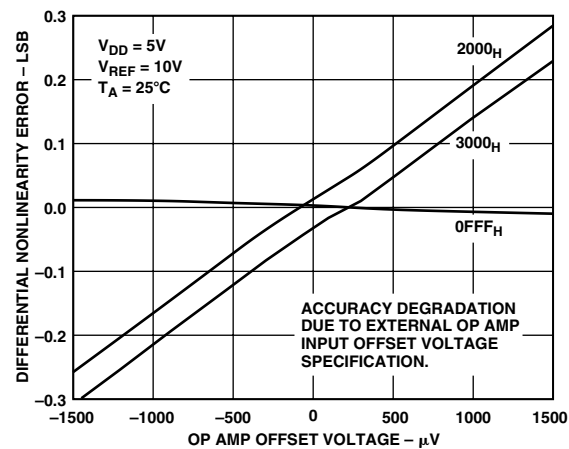
TPC 8. AD5544 Gain Error vs. Op Amp Offset



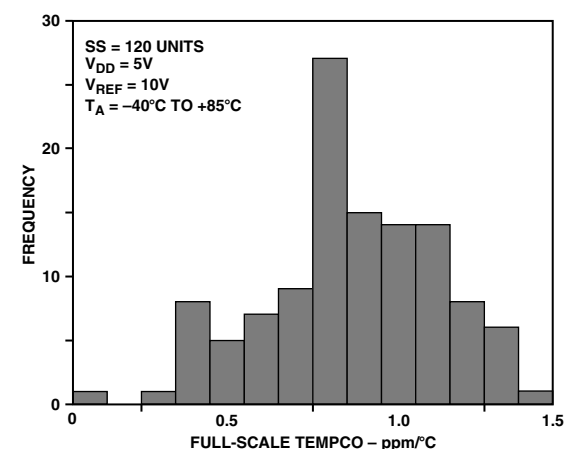
TPC 6. AD5544 Differential Nonlinearity Error vs. Op Amp Offset



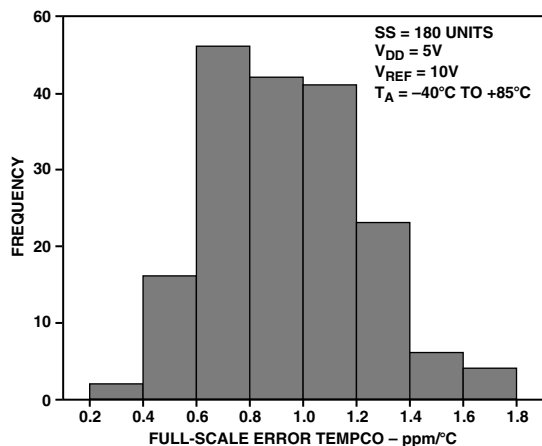
TPC 9. AD5554 Gain Error vs. Op Amp Offset



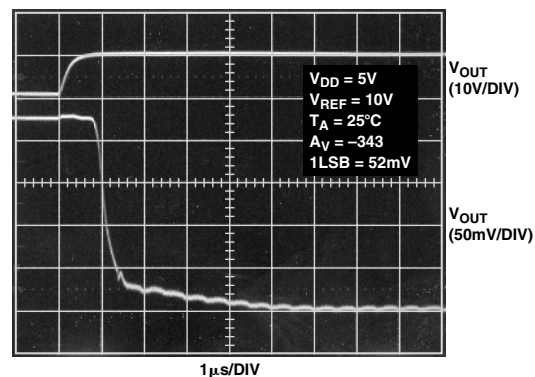
TPC 7. AD5554 Differential Nonlinearity Error vs. Op Amp Offset



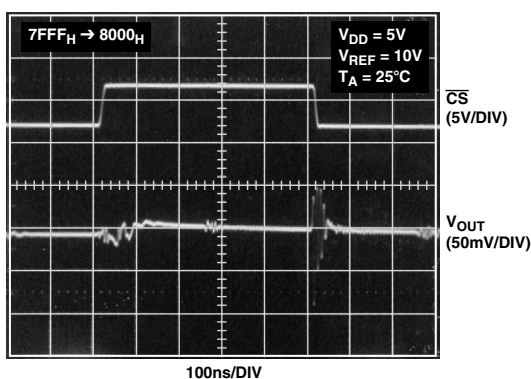
TPC 10. AD5544 Full-Scale Tempco (ppm/°C)



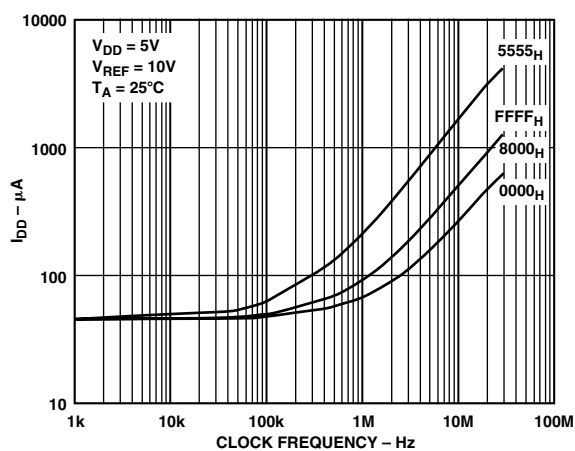
TPC 11. AD5544 Full-Scale Tempco (ppm/ $^{\circ}C$)



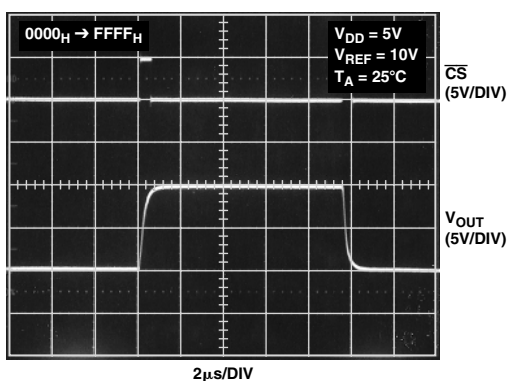
TPC 14. AD5544 Small Signal Settling Time



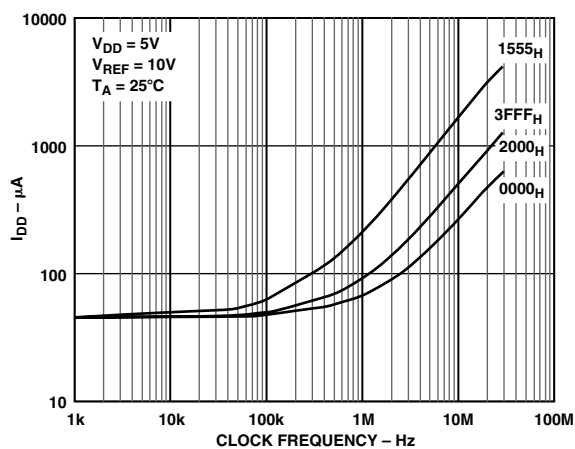
TPC 12. AD5544 Midscale Transition



TPC 15. AD5544 Power Supply Current vs. Clock Frequency

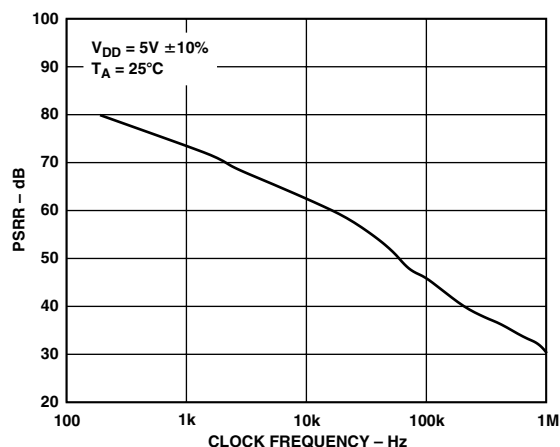


TPC 13. AD5544 Large Signal Settling Time

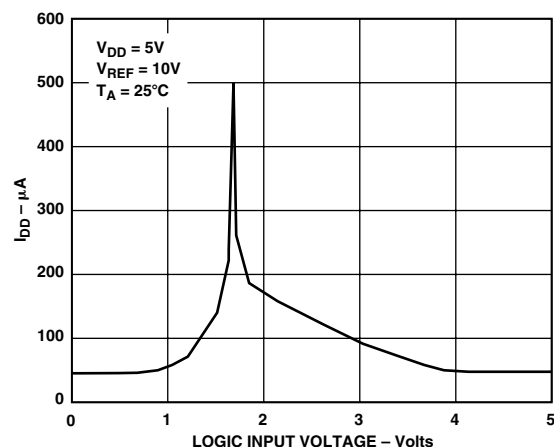


TPC 16. AD5554 Power Supply Current vs. Clock Frequency

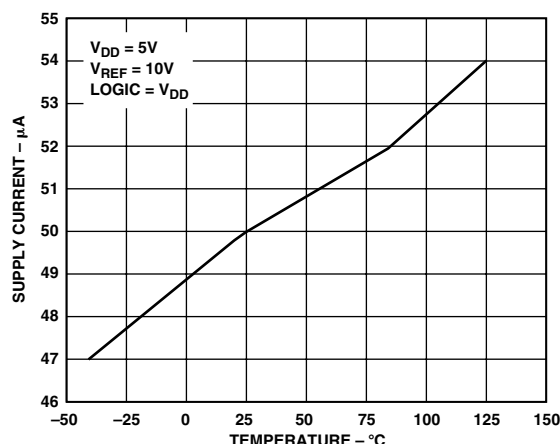
AD5544/AD5554



TPC 17. AD5544/AD5554 Power Supply Rejection vs. Frequency



TPC 19. AD5544/AD5554 Power Supply Current vs. Logic Input Voltage



TPC 18. AD5544/AD5554 Power Supply Current vs. Temperature

CIRCUIT OPERATION

The AD5544 and AD5554 contain four, 16-bit and 14-bit, current-output, digital-to-analog converters respectively. Each DAC has its own independent multiplying reference input. Both AD5544/AD5554 use 3-wire SPI compatible serial data interface, with a configurable asynchronous $\overline{RS}$ pin for half-scale (MSB = 1) or zero-scale (MSB = 0) preset. In addition, an $\overline{LDAC}$ strobe enables four channel simultaneous updates for hardware synchronized output voltage changes.

D/A Converter Section

Each part contains four current-steering R-2R ladder DACs. Figure 4 shows a typical equivalent DAC. Each DAC contains a matching feedback resistor for use with an external I-to-V converter amplifier. The $R_{FB}X$ pin is connected to the output of the external amplifier. The $I_{OUT}X$ terminal is connected to the inverting input of the external amplifier. The $A_{GND}X$ pin should be Kelvin-connected to the load point in the circuit requiring the full 16-bit accuracy. These DACs are designed to operate

with both negative or positive reference voltages. The V_{DD} power pin is only used by the logic to drive the DAC switches ON and OFF. Note that a matching switch is used in series with the internal 5 k Ω feedback resistor. If users are attempting to measure the value of R_{FB} , power must be applied to V_{DD} in order to achieve continuity. An additional V_{SS} bias pin is used to guard the substrate during high temperature applications to minimize zero-scale leakage currents that double every 10°C. The DAC output voltage is determined by V_{REF} and the digital data (D) as:

$$V_{OUT} = -V_{REF} \times \frac{D}{65536} \quad (\text{For AD5544}) \quad (\text{Equation 1})$$

$$V_{OUT} = -V_{REF} \times \frac{D}{16384} \quad (\text{For AD5554}) \quad (\text{Equation 2})$$

Note that the output polarity is opposite to the V_{REF} polarity for dc reference voltages.

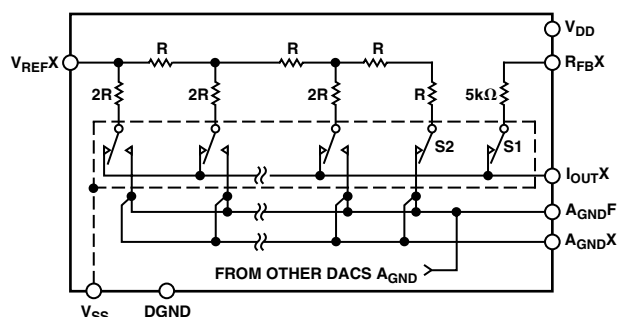


Figure 4. Typical Equivalent DAC Channel

These DACs are also designed to accommodate ac reference input signals. Both AD5544/AD5554 will accommodate input reference voltages in the range of -12 V to $+12\text{ V}$. The reference voltage inputs exhibit a constant nominal input resistance of $5\text{ k}\Omega$, $\pm 30\%$. On the other hand, the DAC outputs I_{OUTA} , B, C, D are code-dependent and produce various output resistances and capacitances. The choice of external amplifier should take into account the variation in impedance generated by the AD5544/AD5554 on the amplifiers' inverting input node. The feedback resistance, in parallel with the DAC ladder resistance, dominates output voltage noise. For multiplying mode applications, an external feedback compensation capacitor (C_{FB}) may be needed to provide a critically damped output response for step changes in reference input voltages. Figures 5 and 6 show the gain vs. frequency performance at various attenuation settings using a 23 pF external feedback capacitor connected across the I_{OUTX} and R_{FBX} terminals for AD5544 and AD5554 respectively. In order to maintain good analog performance, power supply bypassing of $0.01\text{ }\mu\text{F}$, in parallel with $1\text{ }\mu\text{F}$, is recommended. Under these conditions, clean power supply with low ripple voltage capability should be used. Switching power supplies is usually not suitable for this application due to the higher ripple voltage and PSS frequency-dependent characteristics. It is best to derive the AD5544/AD5554's 5 V supply from the systems' analog supply voltages. (Do not use the digital 5 V supply.) See Figure 7.

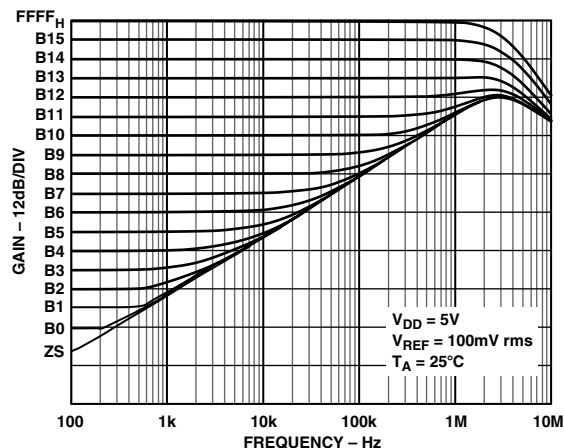


Figure 5. AD5554 Reference Multiplying Bandwidth vs. Code

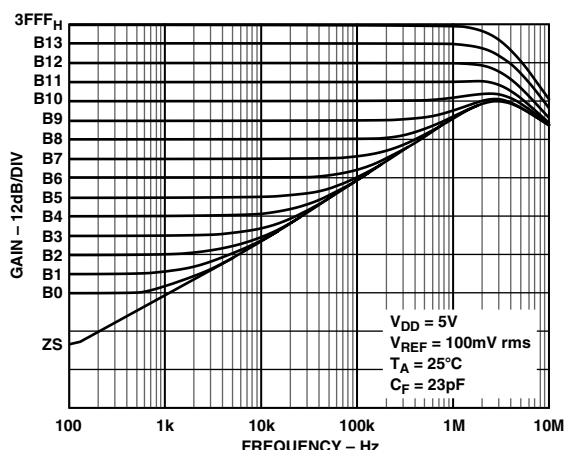


Figure 6. AD5554 Reference Multiplying Bandwidth vs. Code

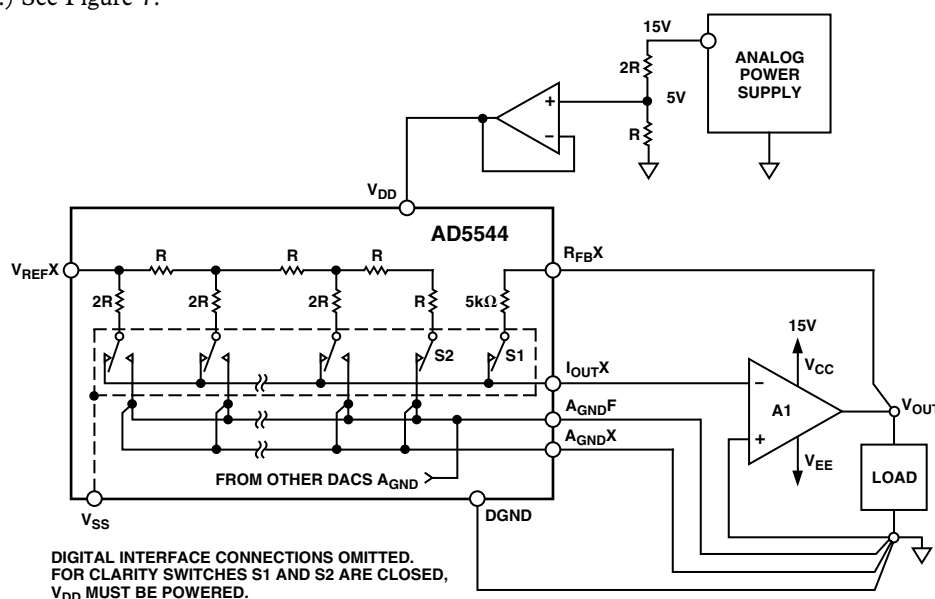


Figure 7. Recommended Kelvin-Sensed Hookup

AD5544/AD5554

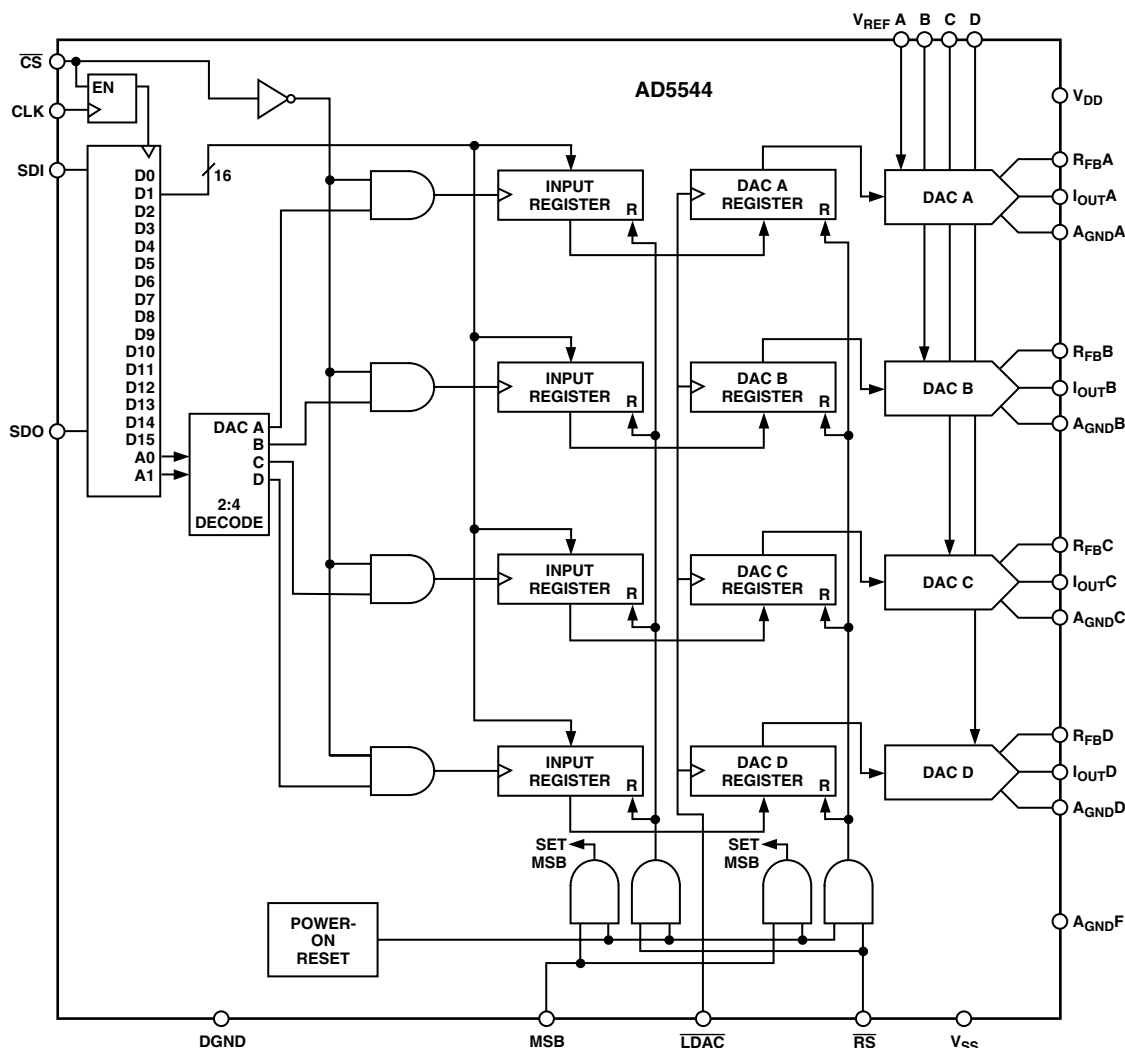


Figure 8. System Level Digital Interfacing

SERIAL DATA INTERFACE

The AD5544/AD5554 uses a 3-wire ($\overline{\text{CS}}$, SDI, CLK) SPI compatible serial data interface. Serial data of AD5544 and AD5554 is clocked into the serial input register in an 18-bit and 16-bit data-word format respectively. MSB bits are loaded first. Table II defines the 18 data-word bits for AD5544. Table III defines the 16 data-word bits for AD5554. Data is placed on the SDI pin, and clocked into the register on the positive clock edge of CLK subject to the data setup and data hold time requirements specified in the Interface Timing Specifications. Data can only be clocked in while the $\overline{\text{CS}}$ chip select pin is active low. For AD5544, only the last 18 bits clocked into the serial register will be interrogated when the $\overline{\text{CS}}$ pin returns to the logic high state, extra data bits are ignored. For AD5554, only the last 16 bits clocked into the serial register will be interrogated when the $\overline{\text{CS}}$ pin returns to the logic high state. Since most microcontrollers output serial data in 8-bit bytes, three right-justified data bytes can be written to the AD5544. Keeping the $\overline{\text{CS}}$ line low between the first, second, and third byte transfers will result in a successful serial register update. Similarly, two right-justified data bytes

can be written to the AD5554. Keeping the $\overline{\text{CS}}$ line low between the first and second byte transfer will result in a successful serial register update.

Once the data is properly aligned in the shift register, the positive edge of the $\overline{\text{CS}}$ initiates the transfer of new data to the target DAC register, determined by the decoding of address bits A1 and A0. For AD5544, Tables I, III, V, and Figure 2 define the characteristics of the software serial interface. For AD5554, Tables II, IV, V, and Figure 3 define the characteristics of the software serial interface. Figures 8 and 9 show the equivalent logic interface for the key digital control pins for AD5544. AD5554 has similar configuration, except with 14 data bits.

Two additional pins $\overline{\text{RS}}$ and MSB provide hardware control over the preset function and DAC Register loading. If these functions are not needed, the $\overline{\text{RS}}$ pin can be tied to logic high. The asynchronous input $\overline{\text{RS}}$ pin forces all input and DAC registers to either the zero-code state (MSB = 0), or the half-scale state (MSB = 1)

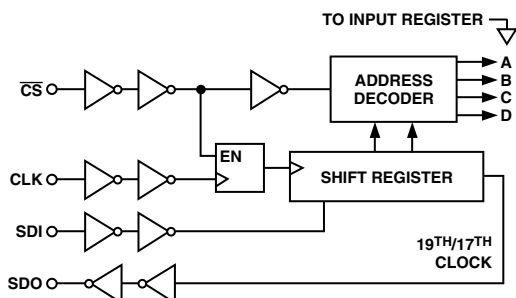


Figure 9. AD5544/AD5554 Equivalent Logic Interface

POWER-ON RESET

When the V_{DD} power supply is turned ON, an internal reset strobe forces all the Input and DAC registers to the zero-code state or half-scale, depending on the MSB pin voltage. The V_{DD} power supply should have a smooth positive ramp without drooping in order to have consistent results, especially in the region of $V_{DD} = 1.5$ V to 2.3 V. The V_{SS} supply has no effect on the power-ON reset performance. The DAC register data will stay at zero or half-scale setting until a valid serial register data load takes place.

ESD Protection Circuits

All logic-input pins contain back-biased ESD protection Zeners connected to ground (DGND) and V_{DD} as shown in Figure 9.

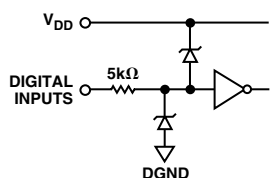


Figure 10. Equivalent ESD Protection Circuits

PCB LAYOUT

In PCB layout, all analog ground, $A_{GND}X$, should be tied together. Amplifiers suitable for I-to-V conversion include:

- High Accuracy: OP97, OP297
- Speed and Accuracy: OP42
- ± 5 V Applications: OP162/OP262/OP462, OP184/OP284/OP484

APPLICATIONS

The AD5544/AD5554 are inherently 2-quadrant multiplying D/A converters. That is, they can be easily set up for unipolar output operation. The full-scale output polarity is the inverse of the reference-input voltage.

In some applications it may be necessary to generate the full 4-quadrant multiplying capability or a bipolar output swing. This is easily accomplished using an additional external amplifier (A2) configured as a summing amplifier (see Figure 11). In this circuit the first and second amplifiers (A1 and A2) provide a total gain-of-2 which increases the output voltage span to 20 V. Biasing the external amplifier with a 10 V offset from the reference voltage results in a full 4-quadrant multiplying circuit. The transfer equation of this circuit shows that both negative and positive output voltages are created as the input data (D) is incremented from code zero ($V_{OUT} = -10$ V) to midscale ($V_{OUT} = 0$ V) to full-scale ($V_{OUT} = 10$ V).

$$V_{OUT} = \left(\frac{D}{32768} - 1 \right) \times V_{REF} \quad (\text{For AD5544}) \quad (\text{Equation 3})$$

$$V_{OUT} = \left(\frac{D}{8192} - 1 \right) \times V_{REF} \quad (\text{For AD5554}) \quad (\text{Equation 4})$$

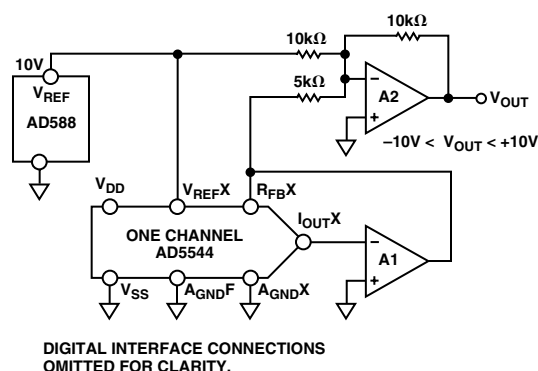


Figure 11. Four-Quadrant Multiplying Application Circuit

OUTLINE DIMENSIONS
Dimensions shown in inches and (mm).

28-Lead SSOP
(RS-28)

